



MGXW6 series Reliability test results

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OS DESIGN DEPT.

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No.	Test Item	Testing conditions	Conditions of acceptability	Number of samples	Number of failures
1	Heat cycle test	(1) $-40^{\circ}\text{C} \sim 125^{\circ}\text{C}$ 30minutes each (2) 800cycles	(1)No degradation of electric characteristics after test. (2)No crack at solder joint.	5	0
2	High temperature/ High humidity bias test	(1) $T_a=85^{\circ}\text{C}$, RH=85% (2) Input Max.Voltege (3) Load 0% (4) 1000hours	(1)No degradation of electric characteristics after test.	5	0
3	Vibration test	(1) $f=10\sim 55\text{Hz}$, $98.0\text{m/s}^2(10\text{G})$ (2) 3minutes period (3) 60minutes each X, Y and Z axis	(1)No degradation of electric characteristics after test. (2)No crack at solder joint. (3)No mechanical damage of appearance.	6	0
4	Impact test	(1) $490.3\text{m/s}^2(50\text{G})$, 11ms (2) Once each X, Y and Z axis	(1)No degradation of electric characteristics after test. (2)No crack at solder joint. (3)No thermal damage of appearance.	3	0
5	Soldering heat test	(1) Soldering iron $340\sim 360^{\circ}\text{C}$, 7.5 seconds (2) Mounting board : $t=1.6\text{mm}$ / FR4	(1)No crack at solder joint. (2)No marked damage of appearance.	1	0
6	Pin solder ability test	(1) Pre-process Step1 Humidifying processing (100°C , 100%, 1H) Step2 Dip into flux (2) Dip soldering $230\sim 240^{\circ}\text{C}$, 2sec	(1)Over 95% of dipped part is covered with solder.	3	0
7	Pin strength test	(1) Weight : 1kg (2) Bending angle : 90 deg., total 180 deg. (3) 1 cycle	(1)No crack at solder joint. (2)No mechanical damage of appearance.	1	0
8	Static electricity immunity test	(1) Applied voltage $\pm 4\text{kV}$ (2) At rated input and load (3) Testing circuitry Fig.1	(1)No protection circuit fail. (2)No output voltage drop due to control (3)No any other function fail.	1	0

○Testing circuitry

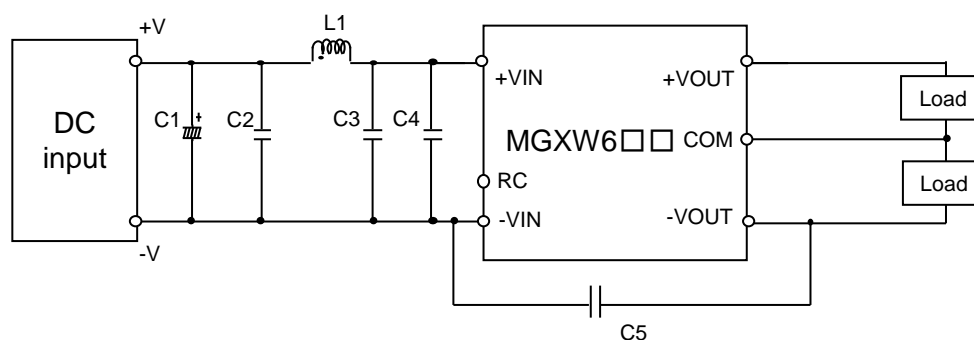


Fig.1 Testing circuitry

C1 :	MGXW624□□	100V 39 μ F Electric capacitor (LXVseries NIPPON CHEMI-CON)
C2 :	MGXW624□□	100V 2.2 μ F Ceramic capacitor (GRM31CR72A225K MURATA MANUFACTURING)
C3 :	MGXW624□□	100V 2.2 μ F Ceramic capacitor (GRM31CR72A225K MURATA MANUFACTURING)
C4 :	MGXW624□□	100V 2.2 μ F Ceramic capacitor (GRM31CR72A225K MURATA MANUFACTURING)
C5 :	MGXW624□□	2kV 2200pF Ceramic capacitor (GR443QR73D222K MURATA MANUFACTURING)
L1 :	MGXW624□□	1050mA 22 μ H Inductor(LQH5BPN220MT0 MURATA MANUFACTURING)